


<b>Search Notes</b>  	<b>Application/Control No.</b>  10666241	<b>Applicant(s)/Patent Under Reexamination</b>  OGAWA ET AL.
	<b>Examiner</b>  Patel, Jayesh A	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	141,144,145,147	02/28/07	JP
356	500,498,496,450	02/28/07	JP

SEARCH NOTES		
Search Notes	Date	Examiner
See attached East Search Report	02/28/07	JP
See updated East (US -pat, PG-pub) IEEE and Inventor search.	11/25/2008	JP
See the updated East, IEEE and the Inventor Search	05/29/2009	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/J. A. P./  
Examiner, Art Unit 2624